## Notice of References Cited Application/Control No. 10/710,338 Examiner Brian E. Miller Applicant(s)/Patent Under Reexamination KUO ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2006/0161929	07-2006	De Hoog et al.	720/602	
*	В	US-2001/0019526	09-2001	Takeda, Kunio	369/75.2	
*	С	US-7,086,729	08-2006	Yoshikaie, Kazuya	347/104	
*	D	US-7,086,068	08-2006	Inoue, Katsuichi	720/602	
*	E	US-6,963,519	11-2005	Otsuki et al.	369/30.36	
*	F	US-6,865,619	03-2005	Reiner, Gerhard	710/17	
*	G	US-6,469,975	10-2002	Yun, Ki-bong	720/602	
*	Н	US-6,005,833	12-1999	Yasuma et al.	720/602	
*	ı	US-5,917,785	06-1999	Masaki et al.	369/44.27	
*	J	US-5,574,711	11-1996	Nakamichi, Niro	720/602	
	K	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09139002 A	05-1997	Japan	ASAKA, KOICHI	
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U						
	V						
	w		9				
	X						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.